


Search Notes 	Application/Control No. 10517250	Applicant(s)/Patent Under Reexamination GORTZ ET AL.
	Examiner David Q Nguyen	Art Unit 2617

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
Update search	03/31/08	DN
East search; Text search	03/31/08	DN
Update search	08/28/08	DN
Text search	08/28/08	DN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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